Notice of References Cited			s Citad	Application/Control No. 10/693,605	Applicant(s)/ Reexaminati INUI ET AL.	Applicant(s)/Patent Under Reexamination INUI ET AL.	
			s Chea	Examiner	Art Unit	David of 4	
				Alain L. Bashore	1762	Page 1 of 1	
				S. PATENT DOCUMENTS			
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name		Classification	
	Α	US-					
	В	US-					
	С	US-					
	D	US-					
	Е	US-					
	F	US-					
	G	US-					
	н	US-					
	ı	US-			•		
	J	US-					
	κ	US-					
	L	US-					
	М	US-					
<u>,</u>				EIGN PATENT DOCUMENTS			
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
	N	,					
	0						
	Р						
	Q						
	R						
	s	***					
	_						
	Т						
	<u> </u>			DN-PATENT DOCUMENTS			
*	Т	Inclu		DN-PATENT DOCUMENTS thor, Title Date, Publisher, Edition or	Volume, Pertinent Pages)		
*	U	Inclu  Machine translation of Japane	de as applicable: Au	thor, Title Date, Publisher, Edition or	Volume, Pertinent Pages)		
*		74	de as applicable: Au	thor, Title Date, Publisher, Edition or			
*		74	de as applicable: Au	thor, Title Date, Publisher, Edition or			
*	U	74	de as applicable: Au	thor, Title Date, Publisher, Edition or			
*	v	74	de as applicable: Au	thor, Title Date, Publisher, Edition or			
*	U	74	de as applicable: Au	thor, Title Date, Publisher, Edition or			

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.